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"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "[Embedded - Microcontrollers](#)"

Details

Product Status	Obsolete
Core Processor	56800EX
Core Size	32-Bit
Speed	50MHz
Connectivity	I ² C, SCI, SPI
Peripherals	DMA, POR, PWM, WDT
Number of I/O	39
Program Memory Size	16KB (8K x 16)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	4K x 8
Voltage - Supply (Vcc/Vdd)	2.7V ~ 3.6V
Data Converters	A/D 10x12b; D/A 2x12b
Oscillator Type	External, Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	48-LQFP
Supplier Device Package	48-LQFP (7x7)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mc56f82316vlf

1.6.5 Comparator

- Full rail-to-rail comparison range
- Support for high and low speed modes
- Selectable input source includes external pins and internal DACs
- Programmable output polarity
- 6-bit programmable DAC as a voltage reference per comparator
- Three programmable hysteresis levels
- Selectable interrupt on rising-edge, falling-edge, or toggle of a comparator output

1.6.6 12-bit Digital-to-Analog Converter

- 12-bit resolution
- Powerdown mode
- Automatic mode allows the DAC to automatically generate pre-programmed output waveforms, including square, triangle, and sawtooth waveforms (for applications like slope compensation)
- Programmable period, update rate, and range
- Output can be routed to an internal comparator, ADC, or optionally to an off-chip destination

1.6.7 Quad Timer

- Four 16-bit up/down counters, with a programmable prescaler for each counter
- Operation modes: edge count, gated count, signed count, capture, compare, PWM, signal shot, single pulse, pulse string, cascaded, quadrature decode
- Programmable input filter
- Counting start can be synchronized across counters
- Up to 100 MHz operation clock

1.6.8 Queued Serial Communications Interface (QSCI) modules

- Operating clock can be up to two times the CPU operating frequency
- Four-word-deep FIFOs available on both transmit and receive buffers
- Standard mark/space non-return-to-zero (NRZ) format
- 16-bit integer and 3-bit fractional baud rate selection
- Full-duplex or single-wire operation
- Programmable 8-bit or 9-bit data format
- Error detection capability

Table 2. Signal descriptions (continued)

Signal Name	48 LQFP	32 LQFP	Type	State During Reset	Signal Description
TMS	47	31	Input	Input, internal pullup enabled	Test Mode Select Input — It is sampled on the rising edge of TCK and has an internal pullup resistor. After reset, the default state is TMS. NOTE: Always tie the TMS pin to V_{DD} through a 2.2K resistor if need to keep on-board debug capability. Otherwise, directly tie to V_{DD} .
(GPIO D3)			Input/ Output		GPIO Port D3
RESET or RESETB	2	2	Input	Input, internal pullup enabled	Reset — A direct hardware reset on the processor. When RESET is asserted low, the device is initialized and placed in the reset state. A Schmitt-trigger input is used for noise immunity. The internal reset signal is deasserted synchronous with the internal clocks after a fixed number of internal clocks. After reset, the default state is RESET . Recommended a capacitor of up to 0.1 μ F for filtering noise.
(GPIO D4)			Input/ Opendrain Output		GPIO Port D4 RESET functionality is disabled in this mode and the device can be reset only through POR, COP reset, or software reset.
GPIOA0	9	6	Input/ Output	Input, internal pullup enabled	GPIO Port A0
(ANA0&CMPA_IN3)			Input		ANA0 is analog input to channel 0 of ADCA; CMPA_IN3 is positive input 3 of analog comparator A. After reset, the default state is GPIOA0.
(CMPC_O)			Output		Analog comparator C output
GPIOA1	10	7	Input/ Output	Input, internal pullup enabled	GPIO Port A1: After reset, the default state is GPIOA1.
(ANA1&CMPA_IN0)			Input		ANA1 is analog input to channel 1 of ADCA; CMPA_IN0 is negative input 0 of analog comparator A. When used as an analog input, the signal goes to ANA1 and CMPA_IN0. The ADC control register configures this input as ANA1 or CMPA_IN0.
GPIOA2	11	8	Input/ Output	Input, internal pullup enabled	GPIO Port A2: After reset, the default state is GPIOA2.
(ANA2&VREFH A&CMPA_IN1)			Input		ANA2 is analog input to channel 2 of ADCA; VREFHA is analog reference high of ADCA; CMPA_IN1 is negative input 1 of analog comparator A. When used as an analog input, the signal goes to both ANA2, VREFHA, and CMPA_IN1.
GPIOA3	12	—	Input/ Output	Input, internal pullup enabled	GPIO Port A3: After reset, the default state is GPIOA3.
(ANA3&VREFL A&CMPA_IN2)			Input		ANA3 is analog input to channel 3 of ADCA; VREFLA is analog reference low of ADCA; CMPA_IN2 is negative input 2 of analog comparator A.
GPIOA4	8	—	Input/ Output	Input, internal pullup enabled	GPIO Port A4: After reset, the default state is GPIOA4.
(ANA4)			Input		ANA4 is Analog input to channel 4 of ADCA.

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Table 2. Signal descriptions (continued)

Signal Name	48 LQFP	32 LQFP	Type	State During Reset	Signal Description
GPIOB0	17	11	Input/ Output	Input, internal pullup enabled	GPIO Port B0: After reset, the default state is GPIOB0.
(ANB0&CMPB_IN3)			Input		ANB0 is analog input to channel 0 of ADCB; CMPB_IN3 is positive input 3 of analog comparator B. When used as an analog input, the signal goes to ANB0 and CMPB_IN3. The ADC control register configures this input as ANB0.
GPIOB1	18	12	Input/ Output	Input, internal pullup enabled	GPIO Port B1: After reset, the default state is GPIOB1.
(ANB1&CMPB_IN0)			Input		ANB1 is analog input to channel 1 of ADCB; CMPB_IN0 is negative input 0 of analog comparator B. When used as an analog input, the signal goes to ANB1 and CMPB_IN0. The ADC control register configures this input as ANB1.
DACB_O			Analog Output		12-bit digital-to-analog output
GPIOB2	20	13	Input/ Output	Input, internal pullup enabled	GPIO Port B2: After reset, the default state is GPIOB2.
(ANB2&VREFHB&CMPC_IN3)			Input		ANB2 is analog input to channel 2 of ADCB; VREFHB is analog reference high of ADCB; CMPC_IN3 is positive input 3 of analog comparator C. When used as an analog input, the signal goes to both ANB2 and CMPC_IN3.
GPIOB3	21	—	Input/ Output	Input, internal pullup enabled	GPIO Port B3: After reset, the default state is GPIOB3.
(ANB3&VREFLB&CMPC_IN0)			Input		ANB3 is analog input to channel 3 of ADCB; VREFLB is analog reference low of ADCB; CMPC_IN0 is negative input 0 of analog comparator C.
GPIOB4	14	—	Input/ Output	Input, internal pullup enabled	GPIO Port B4: After reset, the default state is GPIOB4.
(ANB4&CMPC_IN1)			Input		ANB4 is analog input to channel 4 of ADCB; CMPC_IN1 is negative input 1 of analog comparator C.
GPIOC0	3	—	Input/ Output	Input, internal pullup enabled	GPIO Port C0: After reset, the default state is GPIOC0.
(EXTAL)			Analog Input		The external crystal oscillator input (EXTAL) connects the internal crystal oscillator input to an external crystal or ceramic resonator.
(CLKIN0)			Input		External clock input 0 ¹
GPIOC1	4	—	Input/ Output	Input, internal pullup enabled	GPIO Port C1: After reset, the default state is GPIOC1.
(XTAL)			Input		The external crystal oscillator output (XTAL) connects the internal crystal oscillator output to an external crystal or ceramic resonator.
GPIOC2	5	3	Input/ Output	Input, internal pullup enabled	GPIO Port C2: After reset, the default state is GPIOC2.
(TXD0)			Output		SCI0 transmit data output or transmit/receive in singlewire operation
(XB_OUT11)			Output		Crossbar module output 11

Table continues on the next page...

Table 2. Signal descriptions (continued)

Signal Name	48 LQFP	32 LQFP	Type	State During Reset	Signal Description
(XB_IN2)			Input		Crossbar module input 2
(CLKO0)			Output		Buffered clock output 0: the clock source is selected by clockout select (CLKOSEL) bits in the clock output select register (CLKOUT) of the SIM.
GPIOC3	6	4	Input/Output	Input, internal pullup enabled	GPIO Port C3: After reset, the default state is GPIOC3.
(TA0)			Input/Output		Quad timer module A channel 0 input/output
(CMPA_O)			Output		Analog comparator A output
(RXD0)			Input		SCI0 receive data input
(CLKIN1)			Input		External clock input 1
GPIOC4	7	5	Input/Output	Input, internal pullup enabled	GPIO Port C4: After reset, the default state is GPIOC4.
(TA1)			Input/Output		Quad timer module A channel 1 input/output
(CMPB_O)			Output		Analog comparator B output
(XB_IN6)			Input		Crossbar module input 6
(EWM_OUT_B)			Output		External Watchdog Module output
GPIOC5	13	—	Input/Output	Input, internal pullup enabled	GPIO Port C5: After reset, the default state is GPIOC5.
(DACA_O)			Analog Output		12-bit digital-to-analog output
(XB_IN7)			Input		Crossbar module input 7
GPIOC6	23	15	Input/Output	Input, internal pullup enabled	GPIO Port C6: After reset, the default state is GPIOC6.
(TA2)			Input/Output		Quad timer module A channel 2 input/output
(XB_IN3)			Input		Crossbar module input 3
(CMP_REF)			Analog Input		Positive input 3 of analog comparator A and B and C.
(SS0_B)			Input/Output		In slave mode, $\overline{SS0_B}$ indicates to the SPI module 0 that the current transfer is to be received.
GPIOC7	24	—	Input/Output	Input, internal pullup enable	GPIO Port C7: After reset, the default state is GPIOC7.
(SS0_B)			Input/Output		In slave mode, $\overline{SS0_B}$ indicates to the SPI module 0 that the current transfer is to be received.
(TXD0)			Output		SCI0 transmit data output or transmit/receive in singlewire operation
(XB_IN8)			Input		Crossbar module input 8
GPIOC8	25	16	Input/Output	Input, internal pullup enabled	GPIO Port C8: After reset, the default state is GPIOC8.
(MISO0)			Input/Output		Master in/slave out for SPI0 — In master mode, MISO0 pin is the data input. In slave mode, MISO0 pin is the data output.

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Table 2. Signal descriptions (continued)

Signal Name	48 LQFP	32 LQFP	Type	State During Reset	Signal Description
					The MISO line of a slave device is placed in the high-impedance state if the slave device is not selected.
(RXD0)			Input		SCI0 receive data input
(XB_IN9)			Input		Crossbar module input 9
(XB_OUT6)			Output		Crossbar module output 6
GPIOC9	26	17	Input/Output	Input, internal pullup enabled	GPIO Port C9: After reset, the default state is GPIOC9.
(SCLK0)			Input/Output		SPI0 serial clock. In master mode, SCLK0 pin is an output, clocking slaved listeners. In slave mode, SCLK0 pin is the data clock input.
(XB_IN4)			Input		Crossbar module input 4
(TXD0)			Output		SCI0 transmit data output or transmit/receive in single wire operation
(XB_OUT8)			Output		Crossbar module output 8
GPIOC10	27	18	Input/Output	Input, internal pullup enabled	GPIO Port C10: After reset, the default state is GPIOC10.
(MOSI0)			Input/Output		Master out/slave in for SPI0 — In master mode, MOSI0 pin is the data output. In slave mode, MOSI0 pin is the data input.
(XB_IN5)			Input		Crossbar module input 5
(MISO0)			Input/Output		Master in/slave out for SPI0 — In master mode, MISO0 pin is the data input. In slave mode, MISO0 pin is the data output. The MISO line of a slave device is placed in the high-impedance state if the slave device is not selected.
(XB_OUT9)			Output		Crossbar module output 9
GPIOC11	29	—	Input/Output	Input, internal pullup enabled	GPIO Port C11: After reset, the default state is GPIOC11.
(SCL0)			Input/Open-drain Output		I ² C0 serial clock
(TXD1)			Output		SCI1 transmit data output or transmit/receive in single wire operation
GPIOC12	30	—	Input/Output	Input, internal pullup enabled	GPIO Port C12: After reset, the default state is GPIOC12.
(SDA0)			Input/Open-drain Output		I ² C0 serial data line
(RXD1)			Input		SCI1 receive data input
GPIOC13	37	—	Input/Output	Input, internal pullup enabled	GPIO Port C13: After reset, the default state is GPIOC13.
(TA3)			Input/Output		Quad timer module A channel 3 input/output
(XB_IN6)			Input		Crossbar module input 6

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Table 2. Signal descriptions (continued)

Signal Name	48 LQFP	32 LQFP	Type	State During Reset	Signal Description
GPIOF0	28	—	Input/Output	Input, internal pullup enabled	GPIO Port F0: After reset, the default state is GPIOF0.
(XB_IN6)			Input		Crossbar module input 6
(SCLK1)			Input/Output		SPI1 serial clock — In master mode, SCLK1 pin is an output, clocking slaved listeners. In slave mode, SCLK1 pin is the data clock input 0.
GPIOF1	38	—	Input/Output	Input, internal pullup enabled	GPIO Port F1: After reset, the default state is GPIOF1.
(CLKO1)			Output		Buffered clock output 1: the clock source is selected by clockout select (CLKOSEL) bits in the clock output select register (CLKOUT) of the SIM.
(XB_IN7)			Input		Crossbar module input 7
GPIOF2	—	19	Input/Output	Input, internal pullup enabled	GPIO Port F2: After reset, the default state is GPIOF2.
(SCL0)			Input/ Open-drain Output		I ² C0 serial clock
(XB_OUT6)			Output		Crossbar module output 6
(MISO1)			Input/Output		Master in/slave out for SPI1 — In master mode, MISO1 pin is the data input. In slave mode, MISO1 pin is the data output. The MISO line of a slave device is placed in the high-impedance state if the slave device is not selected.
GPIOF3	—	20	Input/Output	Input, internal pullup enabled	GPIO Port F3: After reset, the default state is GPIOF3.
(SDA0)			Input/ Open-drain Output		I ² C0 serial data line
(XB_OUT7)			Output		Crossbar module output 7
(MOSI1)			Input/Output		Master out/slave in for SPI1— In master mode, MOSI1 pin is the data output. In slave mode, MOSI1 pin is the data input.

1. If CLKIN is selected as the device's external clock input, then both the GPS_C0 bit (in GPS1) and the EXT_SEL bit (in OCCS oscillator control register (OSCTL)) must be set. Also, the crystal oscillator should be powered down.

2.1 Signal groups

The input and output signals of the MC56F8F823xx are organized into functional groups, as detailed in [Table 3](#).

Symbol	Description	Min.	Max.	Unit
V _{DD}	1.0 V core supply voltage	0.9	1.1	V

5.2 Definition: Operating behavior

Unless otherwise specified, an *operating behavior* is a specified value or range of values for a technical characteristic that are guaranteed during operation if you meet the operating requirements and any other specified conditions.

5.2.1 Example

This is an example of an operating behavior:

Symbol	Description	Min.	Max.	Unit
I _{WP}	Digital I/O weak pullup/pulldown current	10	130	μA

5.3 Definition: Attribute

An *attribute* is a specified value or range of values for a technical characteristic that are guaranteed, regardless of whether you meet the operating requirements.

5.3.1 Example

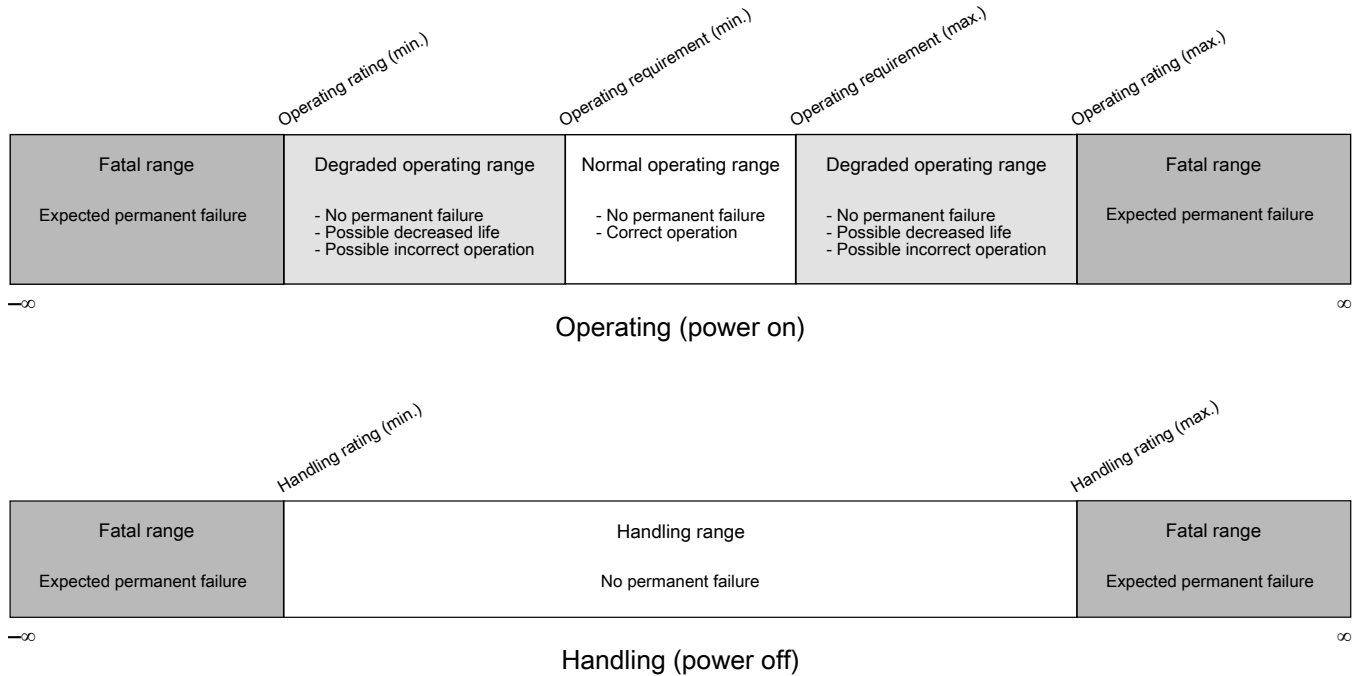
This is an example of an attribute:

Symbol	Description	Min.	Max.	Unit
CIN_D	Input capacitance: digital pins	—	7	pF

5.4 Definition: Rating

A *rating* is a minimum or maximum value of a technical characteristic that, if exceeded, may cause permanent chip failure:

5.6 Relationship between ratings and operating requirements



5.7 Guidelines for ratings and operating requirements

Follow these guidelines for ratings and operating requirements:

- Never exceed any of the chip's ratings.
- During normal operation, don't exceed any of the chip's operating requirements.
- If you must exceed an operating requirement at times other than during normal operation (for example, during power sequencing), limit the duration as much as possible.

5.8 Definition: Typical value

A *typical value* is a specified value for a technical characteristic that:

- Lies within the range of values specified by the operating behavior
- Given the typical manufacturing process, is representative of that characteristic during operation when you meet the typical-value conditions or other specified conditions

Typical values are provided as design guidelines and are neither tested nor guaranteed.

Table 5. Absolute Maximum Ratings ($V_{SS} = 0\text{ V}$, $V_{SSA} = 0\text{ V}$) (continued)

Characteristic	Symbol	Notes ¹	Min	Max	Unit
ADC High Voltage Reference	V_{REFHx}		-0.3	4.0	V
Voltage difference V_{DD} to V_{DDA}	ΔV_{DD}		-0.3	0.3	V
Voltage difference V_{SS} to V_{SSA}	ΔV_{SS}		-0.3	0.3	V
Digital Input Voltage Range	V_{IN}	Pin Group 1	-0.3	5.5	V
$\overline{\text{RESET}}$ Input Voltage Range	V_{IN_RESET}	Pin Group 2	-0.3	4.0	V
Oscillator Input Voltage Range	V_{OSC}	Pin Group 4	-0.4	4.0	V
Analog Input Voltage Range	V_{INA}	Pin Group 3	-0.3	4.0	V
Input clamp current, per pin ($V_{IN} < V_{SS} - 0.3\text{ V}$) ^{2, 3}	V_{IC}		—	-5.0	mA
Output clamp current, per pin ⁴	V_{OC}		—	± 20.0	mA
Contiguous pin DC injection current—regional limit sum of 16 contiguous pins	I_{ICont}		-25	25	mA
Output Voltage Range (normal push-pull mode)	V_{OUT}	Pin Group 1, 2	-0.3	4.0	V
Output Voltage Range (open drain mode)	V_{OUTOD}	Pin Group 1	-0.3	5.5	V
$\overline{\text{RESET}}$ Output Voltage Range	V_{OUTOD_RESET}	Pin Group 2	-0.3	4.0	V
DAC Output Voltage Range	V_{OUT_DAC}	Pin Group 5	-0.3	4.0	V
Ambient Temperature	T_A	V temperature	-40	105	°C
Junction Temperature	T_J	V temperature	-40	125	°C
Storage Temperature Range (Extended Industrial)	T_{STG}		-55	150	°C

1. Default Mode

- Pin Group 1: GPIO, TDI, TDO, TMS, TCK
- Pin Group 2: $\overline{\text{RESET}}$
- Pin Group 3: ADC and Comparator Analog Inputs
- Pin Group 4: XTAL, EXTAL
- Pin Group 5: DAC analog output

2. Continuous clamp current

3. All 5 volt tolerant digital I/O pins are internally clamped to V_{SS} through a ESD protection diode. There is no diode connection to V_{DD} . If V_{IN} greater than V_{DIO_MIN} ($= V_{SS} - 0.3\text{ V}$) is observed, then there is no need to provide current limiting resistors at the pads. If this limit cannot be observed, then a current limiting resistor is required.

4. I/O is configured as push-pull mode.

7 General

7.1 General characteristics

The device is fabricated in high-density, low-power CMOS with 5 V–tolerant TTL-compatible digital inputs, except for the $\overline{\text{RESET}}$ pin which is 3.3V only. The term “5 V–tolerant” refers to the capability of an I/O pin, built on a 3.3 V–compatible process technology, to withstand a voltage up to 5.5 V without damaging the device.

5 V–tolerant I/O is desirable because many systems have a mixture of devices designed for 3.3 V and 5 V power supplies. In such systems, a bus may carry both 3.3 V– and 5 V–compatible I/O voltage levels (a standard 3.3 V I/O is designed to receive a maximum voltage of $3.3\text{ V} \pm 10\%$ during normal operation without causing damage). This 5 V–tolerant capability therefore offers the power savings of 3.3 V I/O levels combined with the ability to receive 5 V levels without damage.

Absolute maximum ratings in [Table 5](#) are stress ratings only, and functional operation at the maximum is not guaranteed. Stress beyond these ratings may affect device reliability or cause permanent damage to the device.

Unless otherwise stated, all specifications within this chapter apply to the temperature range specified in [Table 5](#) over the following supply ranges: $V_{SS}=V_{SSA}=0\text{V}$, $V_{DD}=V_{DDA}=3.0\text{V}$ to 3.6V , $CL \leq 50\text{ pF}$, $f_{OP}=50\text{MHz}$.

CAUTION

This device contains protective circuitry to guard against damage due to high static voltage or electrical fields. However, normal precautions are advised to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate voltage level.

7.2 AC electrical characteristics

Tests are conducted using the input levels specified in [Table 8](#). Unless otherwise specified, propagation delays are measured from the 50% to the 50% point, and rise and fall times are measured between the 10% and 90% points, as shown in [Figure 3](#).

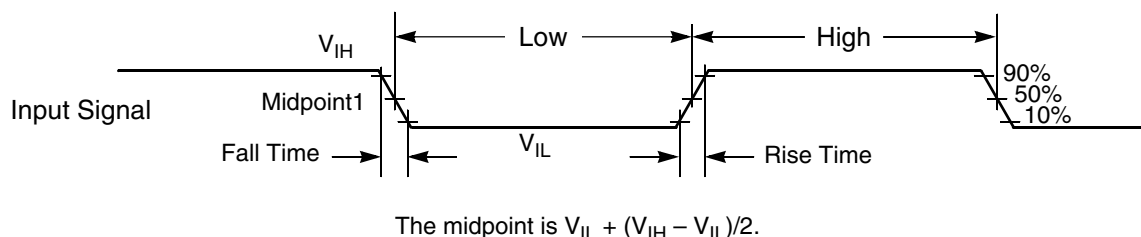


Figure 3. Input signal measurement references

[Figure 4](#) shows the definitions of the following signal states:

- Active state, when a bus or signal is driven, and enters a low impedance state
- Tri-stated, when a bus or signal is placed in a high impedance state
- Data Valid state, when a signal level has reached V_{OL} or V_{OH}
- Data Invalid state, when a signal level is in transition between V_{OL} and V_{OH}

Table 10. Power mode transition behavior (continued)

Symbol	Description	Min	Max	Unit	Notes ¹
	VLPS mode to VLPRUN mode	1424	1459	μs	4
	WAIT mode to RUN mode	0.570	0.620	μs	5
	LPWAIT mode to LPRUN mode	237.2	554	μs	3
	VLPWAIT mode to VLPRUN mode	1413	1500	μs	4

1. Wakeup times are measured from GPIO toggle for wakeup till GPIO toggle at the wakeup interrupt subroutine from respective stop/wait mode.
2. Clock configuration: CPU clock=4 MHz. System clock source is 8 MHz IRC in normal mode.
3. CPU clock = 200 KHz and 8 MHz IRC on standby. Exit by an interrupt on PORTC GPIO.
4. Using 64 KHz external clock; CPU Clock = 32KHz. Exit by an interrupt on PortC GPIO.
5. Clock configuration: CPU and system clocks= 50 MHz. Bus Clock = 50 MHz. .Exit by interrupt on PORTC GPIO

7.3.5 Power consumption operating behaviors

Table 11. Current Consumption (mA)

Mode	Maximum Frequency	Conditions	Typical at 3.3 V, 25°C		Maximum at 3.6 V, 105°C	
			I _{DD} ¹	I _{DDA}	I _{DD} ¹	I _{DDA}
RUN	50 MHz	• 50 MHz Core and Peripheral clock • Regulators are in full regulation • Relaxation Oscillator on • PLL powered on • Continuous MAC instructions with fetches from Program Flash • All peripheral modules enabled. TMRs and SCIs using 1X peripheral clock • ADC/DAC (only one 12-bit DAC and all 6-bit DACs) powered on and clocked • Comparator powered on	27.6	9.9	43.5	13.2
WAIT	50 MHz	• 50 MHz Core and Peripheral clock • Regulators are in full regulation • Relaxation Oscillator on • PLL powered on • Processor Core in WAIT state • All Peripheral modules enabled. • TMRs and SCIs using 1X Clock • ADC/DAC (single 12-bit DAC, all 6-bit DACs), Comparator powered off	24.0	—	41.3	—
STOP	4 MHz	• 4 MHz Device Clock • Regulators are in full regulation • Relaxation Oscillator on • PLL powered off • Processor Core in STOP state • All peripheral module and core clocks are off • ADC/DAC/Comparator powered off	6.3	—	19.4	—
LPRUN (LsRUN)	2 MHz	• 200 kHz Device Clock from Relaxation Oscillator's (ROSC) low speed clock	2.8	3.1	11.1	4.0

Table continues on the next page...

Table 11. Current Consumption (mA)

Mode	Maximum Frequency	Conditions	Typical at 3.3 V, 25°C		Maximum at 3.6 V, 105°C	
			I _{DD} ¹	I _{DDA}	I _{DD} ¹	I _{DDA}
		• PLL disabled • All peripheral modules, except COP, disabled and clocks gated off • Processor core in stop mode				

1. No output switching, all ports configured as inputs, all inputs low, no DC loads.

7.3.6 Designing with radiated emissions in mind

To find application notes that provide guidance on designing your system to minimize interference from radiated emissions:

1. Go to www.freescale.com.
2. Perform a keyword search for “EMC design.”

7.3.7 Capacitance attributes

Table 12. Capacitance attributes

Description	Symbol	Min.	Typ.	Max.	Unit
Input capacitance	C _{IN}	—	10	—	pF
Output capacitance	C _{OUT}	—	10	—	pF

7.4 Switching specifications

7.4.1 Device clock specifications

Table 13. Device clock specifications

Symbol	Description	Min.	Max.	Unit	Notes
Normal run mode					
f _{SYCLK}	Device (system and core) clock frequency • using relaxation oscillator • using external clock source	0.001 0	50 50	MHz	
f _{BUS}	Bus clock	—	50	MHz	

7.4.2 General switching timing

Table 14. Switching timing

Symbol	Description	Min	Max	Unit	Notes
	GPIO pin interrupt pulse width ¹ Synchronous path	1.5		IP Bus Clock Cycles	
	Port rise and fall time (high drive strength), Slew disabled $2.7 \leq V_{DD} \leq 3.6V$.	5.5	15.1	ns	
	Port rise and fall time (high drive strength), Slew enabled $2.7 \leq V_{DD} \leq 3.6V$.	1.5	6.8	ns	2
	Port rise and fall time (low drive strength). Slew disabled $2.7 \leq V_{DD} \leq 3.6V$	8.2	17.8	ns	
	Port rise and fall time (low drive strength). Slew enabled $2.7 \leq V_{DD} \leq 3.6V$	3.2	9.2	ns	3

1. Applies to a pin only when it is configured as GPIO and configured to cause an interrupt by appropriately programming GPIO_n_IPOLR and GPIO_n_IENR.
2. 75 pF load
3. 15 pF load

7.5 Thermal specifications

7.5.1 Thermal operating requirements

Table 15. Thermal operating requirements

Symbol	Description	Min	Max	Unit
T_J	Die junction temperature	-40	125	°C
T_A	Ambient temperature	-40	105	°C

7.5.2 Thermal attributes

This section provides information about operating temperature range, power dissipation, and package thermal resistance. Power dissipation on I/O pins is usually small compared to the power dissipation in on-chip logic and voltage regulator circuits, and it is user-determined rather than being controlled by the MCU design. To account for $P_{I/O}$ in power calculations, determine the difference between actual pin voltage and V_{SS} or V_{DD} and multiply by the pin current for each I/O pin. Except in cases of unusually high pin current (heavy loads), the difference between pin voltage and V_{SS} or V_{DD} is very small.

8.2 System modules

8.2.1 Voltage regulator specifications

The voltage regulator supplies approximately 1.2 V to the MC56F82xxx's core logic. For proper operations, the voltage regulator requires an external 2.2 μF capacitor on each V_{CAP} pin. Ceramic and tantalum capacitors tend to provide better performance tolerances. The output voltage can be measured directly on the V_{CAP} pin. The specifications for this regulator are shown in [Table 17](#).

Table 17. Regulator 1.2 V parameters

Characteristic	Symbol	Min	Typ	Max	Unit
Output Voltage ¹	V_{CAP}	—	1.22	—	V
Short Circuit Current ²	I_{SS}	—	600	—	mA
Short Circuit Tolerance (V_{CAP} shorted to ground)	T_{RSC}	—	—	30	Minutes

1. Value is after trim

2. Guaranteed by design

Table 18. Bandgap electrical specifications

Characteristic	Symbol	Min	Typ	Max	Unit
Reference Voltage (after trim)	V_{REF}	—	1.21	—	V

8.3 Clock modules

8.3.1 External clock operation timing

Parameters listed are guaranteed by design.

Table 19. External clock operation timing requirements

Characteristic	Symbol	Min	Typ	Max	Unit
Frequency of operation (external clock driver) ¹	f_{osc}	—	—	50	MHz
Clock pulse width ²	t_{PW}	8			ns
External clock input rise time ³	t_{rise}	—	—	1	ns
External clock input fall time ⁴	t_{fall}	—	—	1	ns
Input high voltage overdrive by an external clock	V_{ih}	$0.85V_{\text{DD}}$	—	—	V
Input low voltage overdrive by an external clock	V_{il}	—	—	$0.3V_{\text{DD}}$	V

Table 27. 12-bit ADC Electrical Specifications (continued)

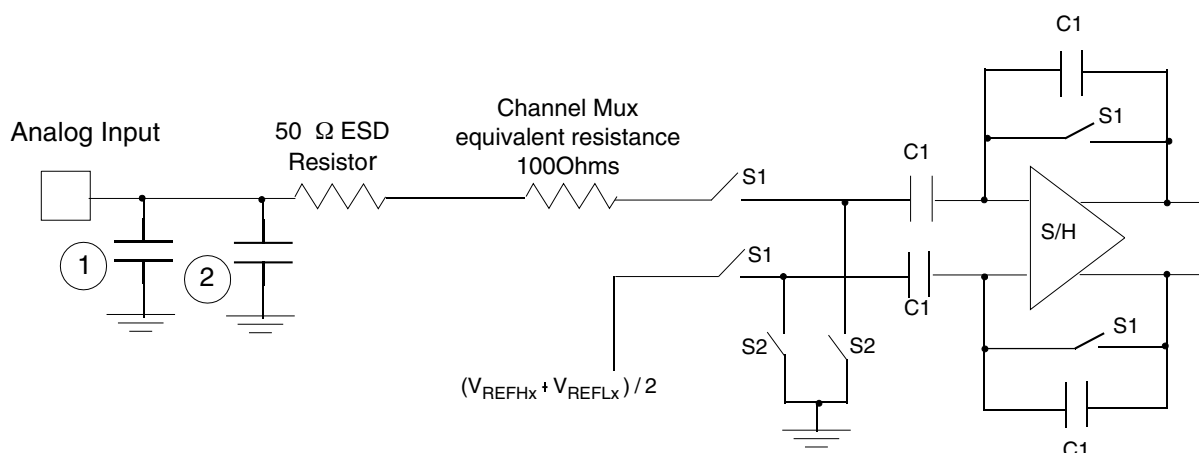
Characteristic	Symbol	Min	Typ	Max	Unit
Spurious Free Dynamic Range	SFDR		77		dB
Signal to Noise plus Distortion	SINAD		66		dB
Effective Number of Bits	ENOB		—		bits
Gain = 1x (Fully Differential/Unipolar)			10.6		
Gain = 2x (Fully Differential/Unipolar)			—		
Gain = 4x (Fully Differential/Unipolar)			10.3		
Gain = 1x (Single Ended)			10.6		
Gain = 2x (Single Ended)			10.4		
Gain = 4x (Single Ended)			10.2		
Variation across channels ¹⁰			0.1		
ADC Inputs					
Input Leakage Current	I_{IN}		1		nA
Temperature sensor slope	T_{SLOPE}		1.7		mV/°C
Temperature sensor voltage at 25 °C	V_{TEMP25}		0.82		V
Disturbance					
Input Injection Current ¹¹	I_{INJ}			+/-3	mA
Channel to Channel Crosstalk ¹²	ISOXTLK		-82		dB
Memory Crosstalk ¹³	MEMXTLK		-71		dB
Input Capacitance	C_{ADI}		4.8		pF
Sampling Capacitor					

1. The ADC functions up to $V_{DDA} = 2.7$ V. When V_{DDA} is below 3.0 V, ADC specifications are not guaranteed
2. ADC clock duty cycle is 45% ~ 55%
3. Conversion range is defined for x1 gain setting. For x2 and x4 the range is 1/2 and 1/4, respectively.
4. In unipolar mode, positive input must be ensured to be always greater than negative input.
5. First conversion takes 10 clock cycles.
6. INL/DNL is measured from $V_{IN} = V_{REFL}$ to $V_{IN} = V_{REFH}$ using Histogram method at x1 gain setting
7. Least Significant Bit = 0.806 mV at 3.3 V V_{DDA} , x1 gain Setting
8. Offset measured at 2048 code
9. Measured converting a 1 kHz input full scale sine wave
10. When code runs from internal RAM
11. The current that can be injected into or sourced from an unselected ADC input without affecting the performance of the ADC
12. Any off-channel with 50 kHz full-scale input to the channel being sampled with DC input (isolation crosstalk)
13. From a previously sampled channel with 50 kHz full-scale input to the channel being sampled with DC input (memory crosstalk).

8.5.1.1 Equivalent circuit for ADC inputs

The following figure shows the ADC input circuit during sample and hold. S1 and S2 are always opened/closed at non-overlapping phases, and both S1 and S2 are dependent on the ADC clock frequency. The following equation gives equivalent input impedance when the input is selected.

$$\frac{1}{(\text{ADC ClockRate}) \times 4.8 \times 10^{-12}} + 100 \text{ ohm} + 50 \text{ ohm}$$



1. Parasitic capacitance due to package, pin-to-pin and pin-to-package base coupling = 1.8pF
2. Parasitic capacitance due to the chip bond pad, ESD protection devices and signal routing = 2.04pF
3. S1 and S2 switch phases are non-overlapping and depend on the ADC clock frequency

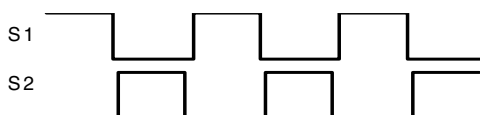


Figure 9. Equivalent circuit for A/D loading

8.5.2 12-bit Digital-to-Analog Converter (DAC) parameters

Table 28. DAC parameters

Parameter	Conditions/Comments	Symbol	Min	Typ	Max	Unit
DC Specifications						
Resolution			12	12	12	bits
Settling time ¹	At output load RLD = 3 kΩ CLD = 400 pF		—	1		μs
Power-up time	Time from release of PWRDWN signal until DACOUT signal is valid	t _{DAPU}	—	—	11	μs
Accuracy						
Integral non-linearity ²	Range of input digital words:	INL	—	+/- 3	+/- 4	LSB ³

Table continues on the next page...

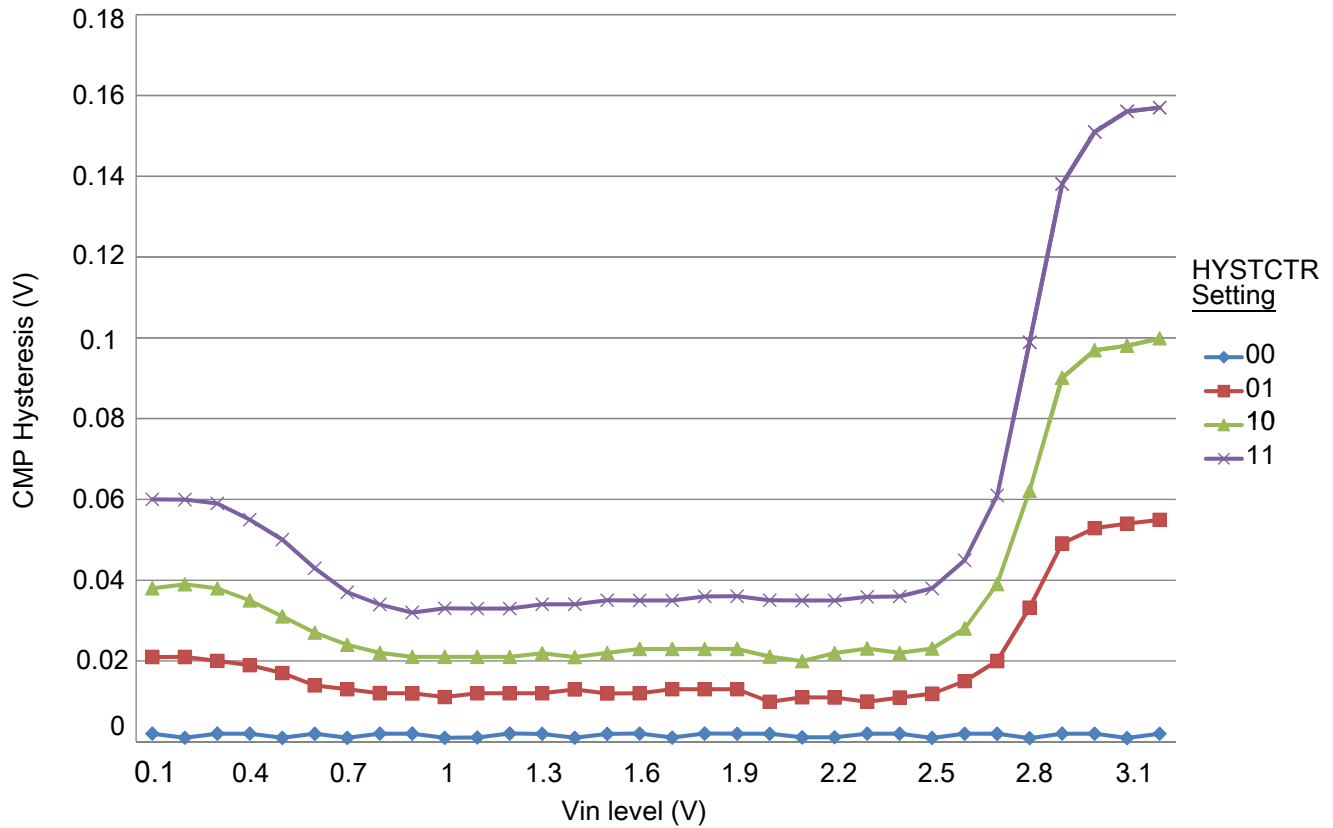


Figure 11. Typical hysteresis vs. Vin level ($V_{DD} = 3.3\text{ V}$, $P_{MODE} = 1$)

8.6 Timer

8.6.1 Quad Timer timing

Parameters listed are guaranteed by design.

Table 30. Timer timing

Characteristic	Symbol	Min ¹	Max	Unit	See Figure
Timer input period	P_{IN}	$2T + 10$	—	ns	Figure 12
Timer input high/low period	P_{INHL}	$1T + 5$	—	ns	Figure 12
Timer output period	P_{OUT}	$2T - 2$	—	ns	Figure 12
Timer output high/low period	P_{OUTHL}	$1T - 2$	—	ns	Figure 12

1. T = clock cycle. For 50 MHz operation, $T = 20\text{ ns}$.

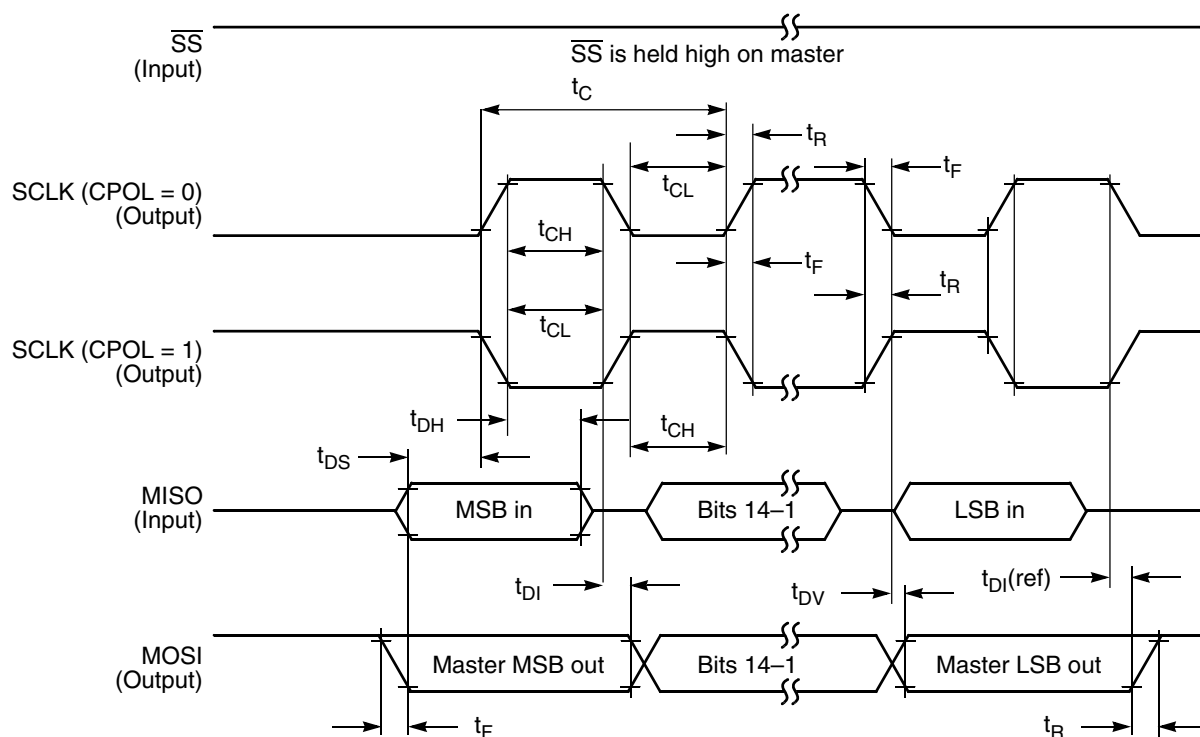


Figure 13. SPI master timing (CPHA = 0)

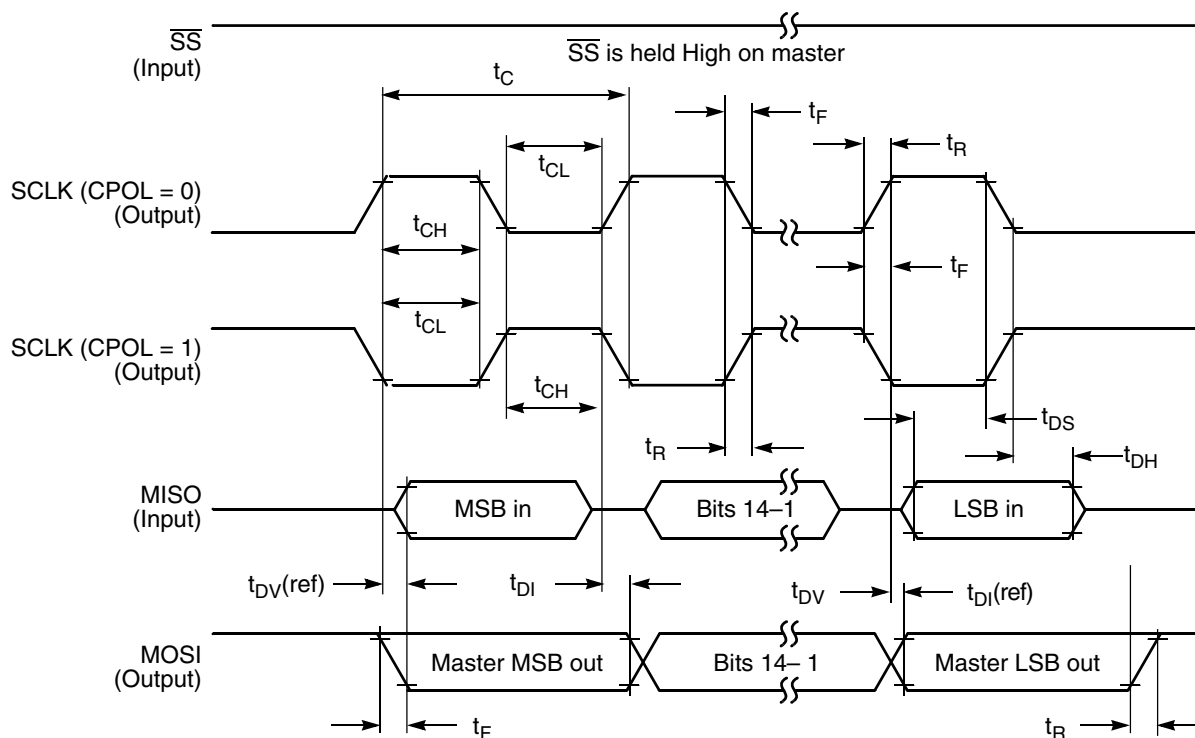


Figure 14. SPI master timing (CPHA = 1)

8.7.2 Queued Serial Communication Interface (SCI) timing

Parameters listed are guaranteed by design.

Table 32. SCI timing

Characteristic	Symbol	Min	Max	Unit	See Figure
Baud rate ¹	BR	—	($f_{MAX}/16$)	Mbit/s	—
RXD pulse width	RXD _{PW}	0.965/BR	1.04/BR	ns	Figure 17
TXD pulse width	TXD _{PW}	0.965/BR	1.04/BR	ns	Figure 18
LIN Slave Mode					
Deviation of slave node clock from nominal clock rate before synchronization	F _{TOL_UNSYNCH}	-14	14	%	—
Deviation of slave node clock relative to the master node clock after synchronization	F _{TOL_SYNCH}	-2	2	%	—
Minimum break character length	T _{BREAK}	13	—	Master node bit periods	—
		11	—	Slave node bit periods	—

1. f_{MAX} is the frequency of operation of the SCI clock in MHz, which can be selected as the bus clock (max.)50 MHz.

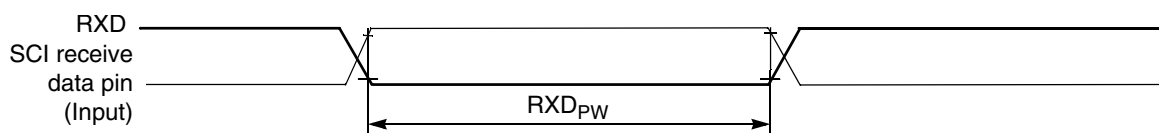


Figure 17. RXD pulse width



Figure 18. TXD pulse width

8.7.3 Inter-Integrated Circuit Interface (I²C) timing

Table 33. I²C timing

Characteristic	Symbol	Standard Mode		Fast Mode		Unit
		Minimum	Maximum	Minimum	Maximum	
SCL Clock Frequency	f_{SCL}	0	100	0	400	kHz
Hold time (repeated) START condition. After this period, the first clock pulse is generated.	t_{HD} ; STA	4	—	0.6	—	μ s
LOW period of the SCL clock	t_{LOW}	4.7	—	1.3	—	μ s

Table continues on the next page...

10 Obtaining package dimensions

Package dimensions are provided in package drawings.

To find a package drawing, go to freescale.com and perform a keyword search for the drawing's document number:

Drawing for package	Document number to be used
32LQFP	98ASH70029A
32QFN	98ASA00473D
48-pin LQFP	98ASH00962A

11 Pinout

11.1 Signal Multiplexing and Pin Assignments

The following table shows the signals available on each pin and the locations of these pins on the devices supported by this document. The SIM's GPS registers are responsible for selecting which ALT functionality is available on most pins.

NOTE

- The RESETB pin is a 3.3 V pin only.
- If the GPIOC1 pin is used as GPIO, the XOSC should be powered down.
- Not all CMPD pins are not available on 48 LQFP.

NOTE

DAC and CMPC signals are not available on 32 LQFP package.

48 LQFP	32 LQFP	Pin Name	Default	ALT0	ALT1	ALT2	ALT3
—	19	GPIOF2	GPIOF2	SCL0	XB_OUT6		
—	20	GPIOF3	GPIOF3	SDA0	XB_OUT7		
1	1	TCK	TCK	GPIOD2			
2	2	RESETB	RESETB	GPIOD4			
3	—	GPIOC0	GPIOC0	EXTAL	CLKIN0		
4	—	GPIOC1	GPIOC1	XTAL			
5	3	GPIOC2	GPIOC2	TXD0	XB_OUT11	XB_IN2	CLK00
6	4	GPIOC3	GPIOC3	TA0	CMPA_O	RXD0	CLKIN1